

Issue Classification

Devin Hanan 1/20/06
Devin Hanan 1/20/2006
(Assistant Examiner) (Date)

Edward K Look 1/21/06
EDWARD K. LOOK
SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 3700
(Primary Examiner) (Date)

Total Claims Allowed: 17	
O.G. Print Claim(s)	O.G. Print Fig.
9	3

☐ Claims renumbered in the same order as presented by applicant☐ CPA

☐ T.D.

□ R.1.47

Final	Original			Final	Original			Final	Original			Final	Original			Final	Original			Final	Original
}	1				31				91				121				151				181
2	2				32				92				122				152				182
3	3				33				93				123				153				183
4	4				34				94				124				154				184
5	5				35				95				125				155				185
6	6				36				96				126				156				186
7	7				37				97				127				157				187
	8				38				98				128				158				188
1	9				39				99				129				159				189
8	10				40				100				130				160				190
9	11				41				101				131				161				191
	12				42				102				132				162				192
11	13				43				103				133				163				193
12	14				44				104				134				164				194
13	15				45				105				135				165				195
14	16				46				106				136				166				196
15	17				47				107				137				167				197
	18				48				108				138				168				198
10	19				49				109				139				169				199
16	20				50				110				140				170				200
)	21				51				111				141				171				201
17	22				52				112				142				172				202
	23				53				113				143				173				203
	24				54				114				144				174				204
	25				55				115				145				175				205
	26				56				116				146				176				206
	27				57				117				147				177				207
	28				58				118				148				178				208
	29				59				119				149				179				209
	30				60				120				150				180				210